L edge RIXS is a direct probe for the electronic excitations in 3d transition metal oxides

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Resonant Inelastic X-ray Scattering (RIXS) can be effectively used to study the low energy electronic excitations in solids. Working at the $L_{2,3}$ absorption edges is ideal in 3*d* transition metals compounds, because the resonant excitation and de-excitation allow us to measure the energy of excited states unreachable by direct electric dipole transitions. Those excited states (among them the so-called *dd* excitations) extend from a few eV down to the tens of millielectronvolt energy scale. As the 2*p* state binding energies of 3*d* transition metals are between 400 eV and 1000 eV, they fall in the energetic range of the soft X-rays of beam line ID08.

We present some recent RIXS spectra measured, with unprecedented energy resolution and data quality, across the L_3 edge of CuO, NiO, CoO, MnO. Those results, obtained on prototypical compounds, can be interpreted within a simple crystal field model, opening the way to the use of RIXS for the study of the 3*d* transition metal ion local coordination in more complicated cases belonging to the rich family of transition metal oxides.